

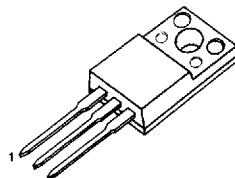
FEATURES

- Lower $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability

PRODUCT SUMMARY

Part Number	V _{DS}	$R_{DS(on)}$	I _D
IRFS9640	-200V	0.50 Ω	-6.2A
IRFS9641	-150V	0.50 Ω	-6.2A

TO-220F



1. Gate 2. Drain 3. Source

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	IRFS9640	IRFS9641	Unit
Drain-Source Voltage (1)	V _{DSS}	-100	-60	V _{dc}
Drain-Gate Voltage ($R_{GS}=1.0M\Omega$) (1)	V _{DGR}	-100	-60	V _{dc}
Gate-Source Voltage	V _{GS}	± 20		V _{dc}
Continuous Drain Current T _c =25 °C	I _D	-6.2		A _{dc}
Continuous Drain Current T _c =100 °C	I _D	-4.7		A _{dc}
Drain Current - Pulsed (3)	I _{DM}	-44		A _{dc}
Gate Current - Pulsed	I _{GM}	± 1.5		A _{dc}
Single Pulsed Avalanche Energy (4)	E _{AS}	120		mJ
Avalanche Current	I _{AS}	-6.2		A
Total Power Dissipation at T _c =25 °C	P _D	40		Watts
Derate above 25 °C		0.32		W/ °C
Operating and Storage Junction Temperature Range	T _J , T _{STG}	-55 to +150		°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T _L	300		°C

Notes : (1) T_J=25°C to 150°C(2) Pulse test : Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

(3) Repetitive rating : Pulse width limited by max. junction temperature

(4) L=7mH, V_{dd}=-50V, R_G=25 Ω , Starting T_J=25°C

ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV _{DSS}	Drain-Source Breakdown Voltage					
	IRFS9640	-200	-	-	V	V _{GS} =0V, I _D =-250μA
	IRFS9641	-150	-	-	V	
V _{GS(th)}	Gate Threshold Voltage	-2.0	-	-4.0	V	V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	Gate-Source Leakage Forward	-	-	-100	nA	V _{GS} =-20V
I _{GSS}	Gate-Source Leakage Reverse	-	-	100	nA	V _{GS} =20V
I _{DSS}	Zero Gate Voltage Drain Current	-	-	-250	μA	V _{DS} =-V _{DS} Max. Rating, V _{GS} =0V
		-	-	-1000	μA	V _{DS} =-0.8 Max. Rating, V _{GS} =0V, T _C =125°C
R _{DS(on)}	Static Drain-Source On Resistance(2)	-	-	0.5	Ω	V _{GS} =-10V, I _D =-5.5A
g _{fs}	Forward Transconductance (2)	4.0	-	-	Ω	V _{DS} =-10V, I _D =-5.5A
C _{iss}	Input Capacitance	-	1542	-	pF	V _{GS} =0V
C _{oss}	Output Capacitance	-	230	-	pF	V _{GS} =0V, V _{DS} =-25V, f=1.0MHz
C _{rss}	Reverse Transfer Capacitance	-	115	-	pF	f=1.0MHz
t _{d(on)}	Turn-On Delay Time	-	-	30	ns	V _{DD} =-100V, I _D =-11A, Z ₀ =9.1Ω
t _r	Rise Time	-	-	15	ns	(MOSFET switching times are essentially independent of operating temperature)
t _{d(off)}	Turn-Off Delay Time	-	-	18	ns	
t _f	Fall Time	-	-	12	ns	
Q _g	Total Gate Charge (Gate-Source Plus Gate-Drain)	-	-	112	nC	V _{GS} =-15V, I _D =-11A, V _{DS} =-0.8 Max. Rating, (Gate charge is essentially independent of operating temperature)
Q _{gs}	Gate-Source Charge	-	27	-	nC	
Q _{gd}	Gate-Drain ("Miller") Charge	-	40	-	nC	

THERMAL RESISTANCE

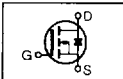
Symbol	Characteristics		All	Units	Remark
R _{thJC}	Junction-to-Case	MAX	3.12	K/W	
R _{thCS}	Case-to-Sink	TYP	0.5	K/W	Mounting surface flat, smooth, and greased
R _{thJA}	Junction-to-Ambient	MAX	62.5	K/W	Free Air Operation

 Notes : (1) T_J=25°C to 150°C

(2) Pulse test : Pulse width ≤ 300μs, Duty Cycle ≤ 2%

(3) Repetitive rating : Pulse width limited by max. junction temperature

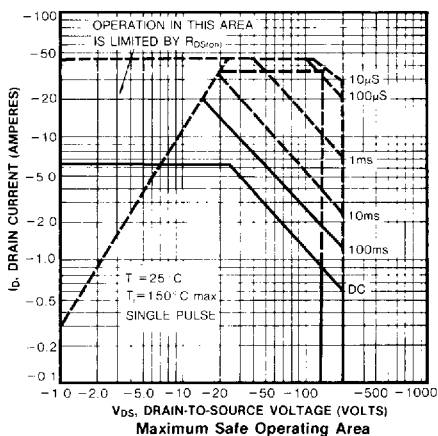
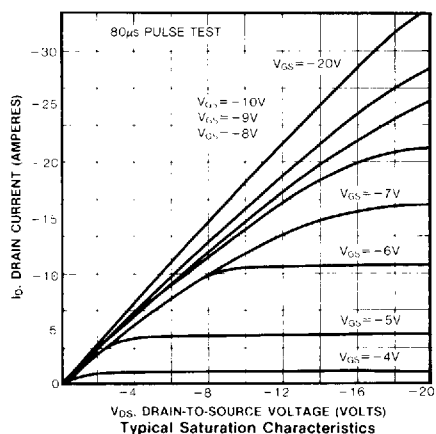
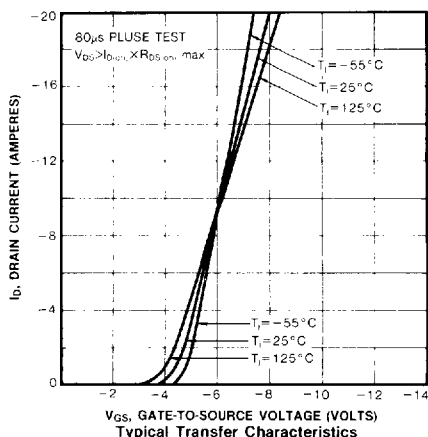
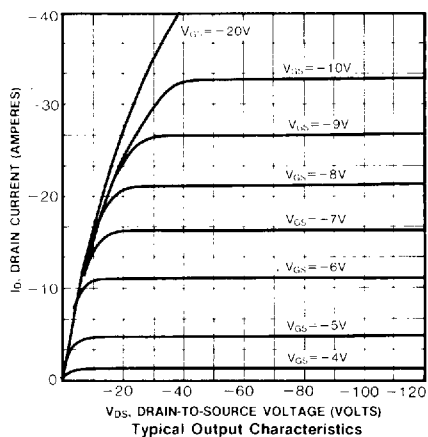
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

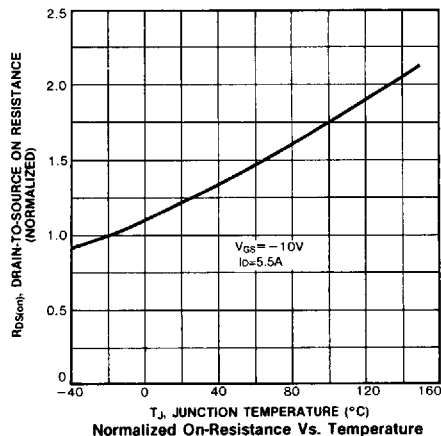
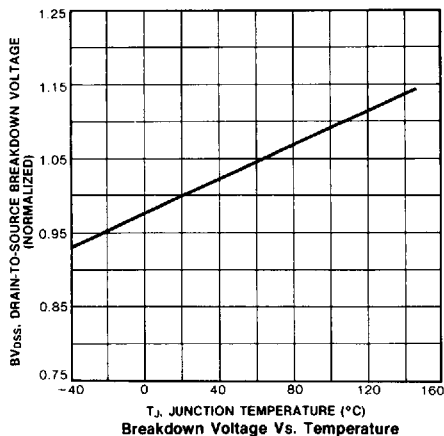
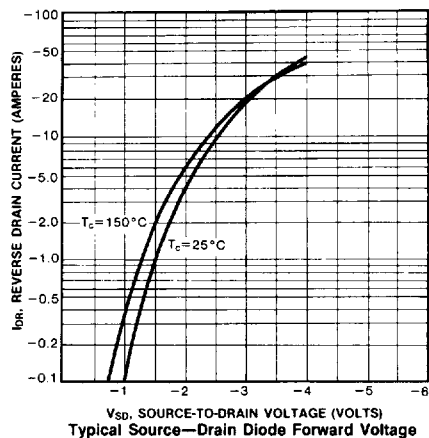
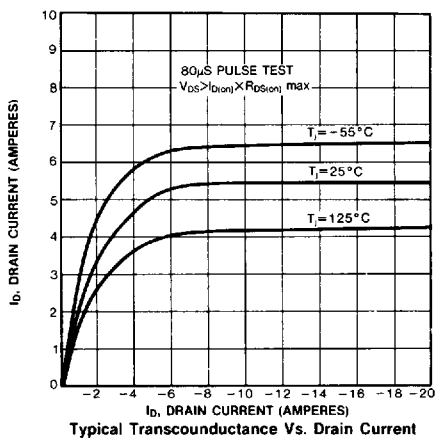
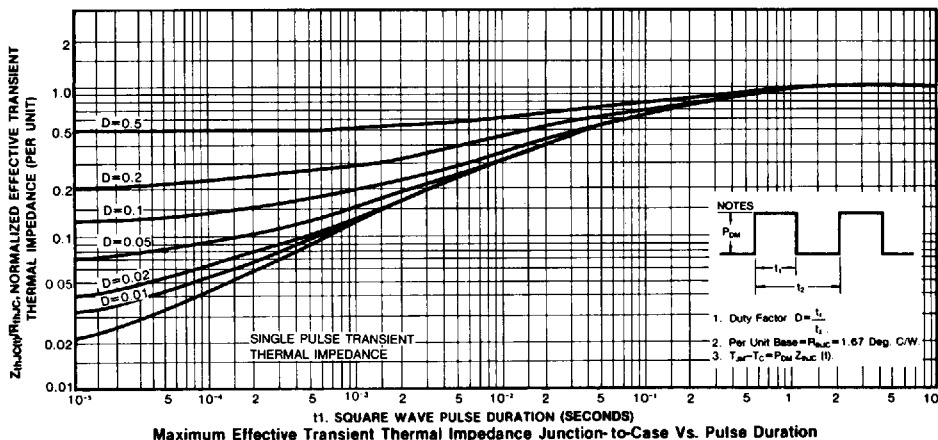
Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	-	-	-11	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier 
I_{SM}	Pulse Source Current (Body Diode) (3)	-	-	-44	A	
V_{SD}	Diode Forward Voltage (2)	-	-	-4.6	V	$T_J=25^\circ\text{C}$, $I_S=-11\text{A}$, $V_{GS}=0\text{V}$
t_{rr}	Reverse Recovery Time	-	270	-	ns	$T_J=25^\circ\text{C}$, $I_F=-11\text{A}$, $dI_F/dt=100\text{A}/\mu\text{S}$

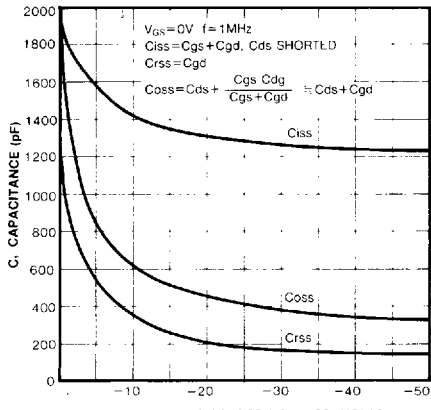
Notes : (1) $T_J=25^\circ\text{C}$ to 150°C

(2) Pulse test : Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

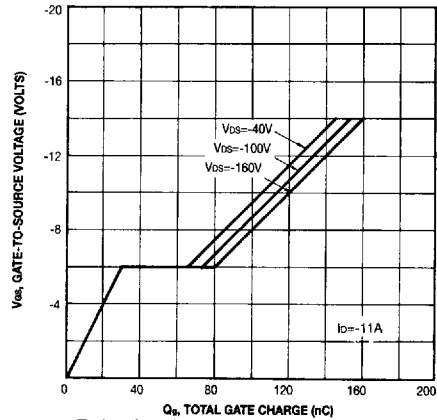
(3) Repetitive rating : Pulse width limited by max. junction temperature



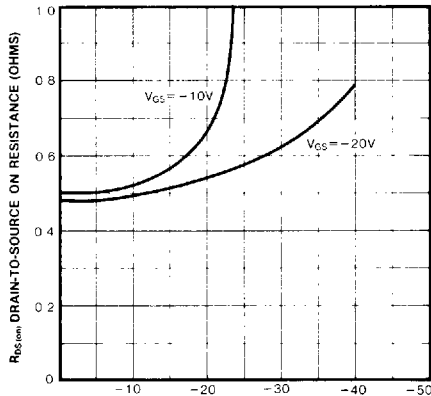




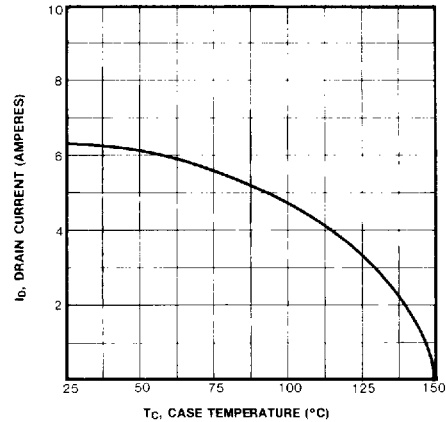
Typical Capacitance Vs. Drain to Source Voltage



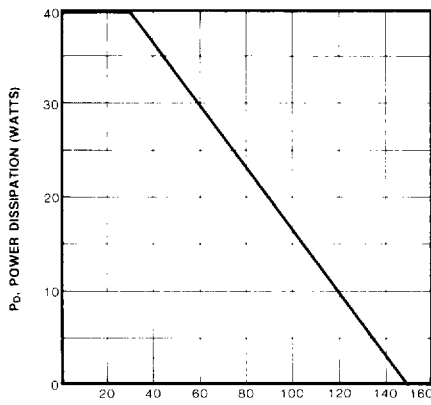
Typical Gate Charge Vs. Gate-to-Source Voltage



Typical On-Resistance Vs. Drain Current



Maximum Drain Current Vs. Case Temperature



Power Vs. Temperature Derating Curve